CRMLTL3018K

N-Channel 30V,474mΩ Typ. Power MOSFET

Description

Features

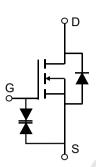
• 30V, 0.6A

$$R_{DS(ON)}$$
 Typ = 474m Ω @ V_{GS} = 10V

$$R_{DS(ON)}$$
 Typ = 643m Ω @ V_{GS} = 4.5V

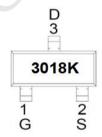
- Advanced Trench Technology
- Excellent R_{DS(ON)} and Low Gate Charge
- Lead Free

• ESD Protected: 2KV









Marking and Pin Assignment

Application

- Load Switch
- PWM Application
- Power Management

Package Marking and Ordering Information

Device	Marking	Package	Outline	Reel Size	Reel (pcs)	Per Carton (pcs)
CRMLTL3018K	3018K	SOT-23	TAPING	7"	3000	120000

Absolute Maximum Ratings (@ T_J = 25°C unless otherwise specified)

Symbol	Parameter		Value	Units
V_{DS}	Drain-to-Source Voltage		30	V
V_{GS}	Gate-to-Source Voltage		±20	V
	Continuous Drain Current	T _A = 25°C	0.6	Α
I _D	Continuous Diain Current	T _A = 100°C	0.36	Α
I _{DM}	Pulsed Drain Current (1)		2.4	Α
P_{D}	Power Dissipation	T _A = 25°C	0.35	W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient ⁽²⁾	2)	357	°C/W
T_J,T_STG	Junction & Storage Temperature Range		-55 to 150	°C

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Electrical Characteristics (T_J = 25°C unless otherwise specified)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Off Char	acteristics					
V _{(BR)DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	30	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 30V, V_{GS} = 0V$	-	-	1.0	μА
I _{GSS}	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	-	-	±10	μА
On Char	acteristics				G	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	0.9	1.2	1.7	V
Б		$V_{GS} = 10V, I_D = 0.2A$	-	474	569	mΩ
$R_{DS(ON)}$	Static Drain-Source ON-Resistance ⁽³⁾	$V_{GS} = 4.5V, I_D = 0.15A$	-	643	772	mΩ
Dynamic	Characteristics					
C _{iss}	Input Capacitance		-6	18	-	pF
C_{oss}	Output Capacitance	$V_{GS} = 0V$, $V_{DS} = 15V$, f = 1MHz	X - \	7	-	pF
C_{rss}	Reverse Transfer Capacitance	1 - 1101112		3	-	pF
Q_g	Total Gate Charge) -	1.7	-	nC
Q_gs	Gate Source Charge	$V_{GS} = 0 \text{ to } 10V$ $V_{DS} = 15V, I_D = 0.3A$	-	0.5	-	nC
Q_{gd}	Gate Drain("Miller") Charge	V _{DS} = 13V, I _D = 0.0A	-	0.7	-	nC
Switchin	g Characteristics					
t _{d(on)}	Turn-On DelayTime	.()	-	1.7	-	ns
t _r	Turn-On Rise Time	$V_{GS} = 10V, V_{DD} = 10V$	-	10	-	ns
$t_{\text{d(off)}}$	Turn-Off DelayTime	I_D = 0.2A, R_{GEN} = 10 Ω	-	10	-	ns
t_f	Turn-Off Fall Time		-	22	-	ns
Drain-So	urce Diode Characteristics and I	Max Ratings				
I _S	Maximum Continuous Drain to Source D	iode Forward Current	-	-	0.6	Α
I _{SM}	Maximum Pulsed Drain to Source Diode	Forward Current	-	-	2.4	Α
V_{SD}	Drain to Source Diode Forward Voltage	$V_{GS} = 0V, I_{S} = 0.2A$	_	_	1.2	V

Notes:

^{1.} Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.

^{2.} $R_{\text{\tiny BJA}}$ is measured with the device mounted on a 1inch² pad of 2oz copper FR4 PCB

^{3.} Pulse Test: Pulse Width≤300µs, Duty Cycle≤0.5%.

Typical Performance Characteristics

Figure 1: Output Characteristics

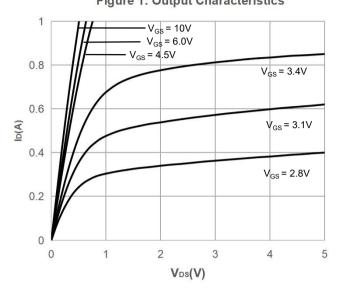


Figure 3: On-resistance vs. Drain Current

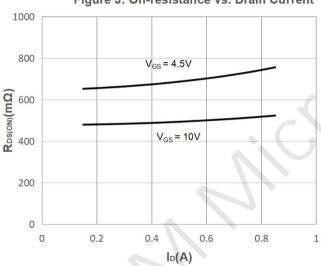


Figure 5: Gate Charge Characteristics

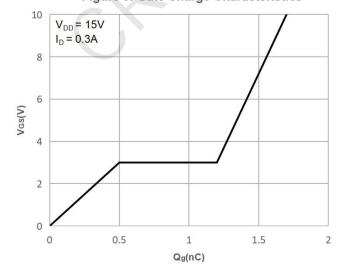


Figure 2: Typical Transfer Characteristics

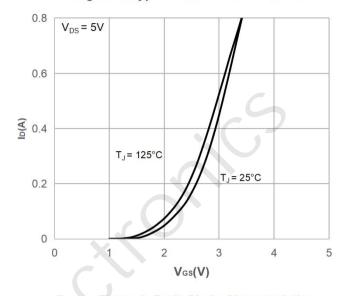


Figure 4: Body Diode Characteristics

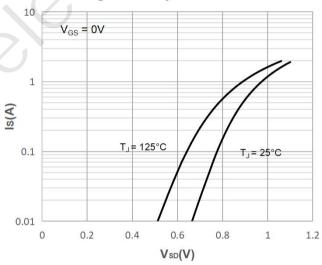
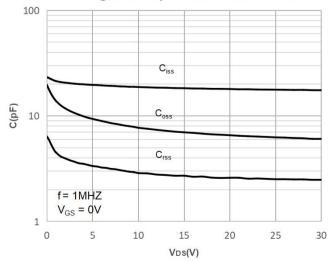


Figure 6: Capacitance Characteristics

Version: 1.1





Typical Performance Characteristics

Figure 7: Normalized Breakdown voltage vs. **Junction Temperature**

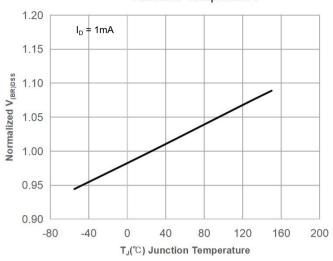


Figure 9: Maximum Safe Operating Area

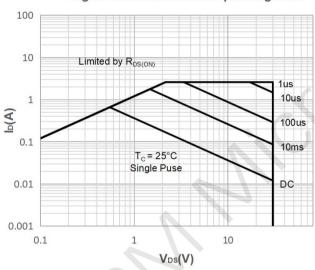


Figure 11: Normalized Maximum Transient

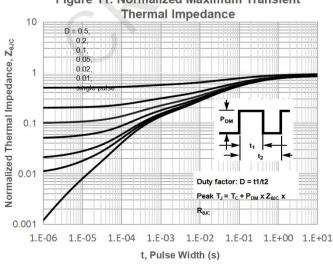


Figure 8: Normalized on Resistance vs. **Junction Temperature**

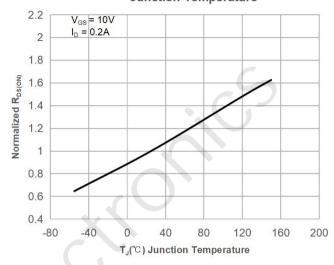


Figure 10: Maximum Continuous Drian **Current vs. Case Temperature**

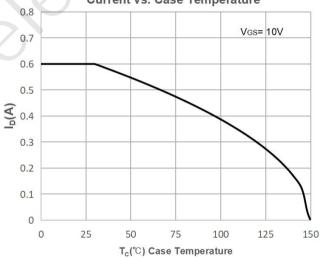
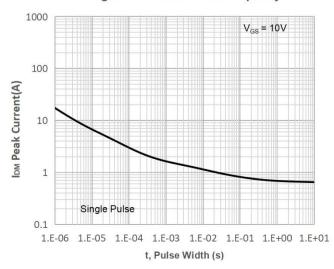


Figure 12: Peak Current Capacity



Version: 1.1

Test Circuit

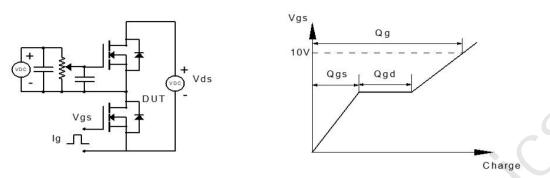


Figure 1: Gate Charge Test Circuit & Waveform

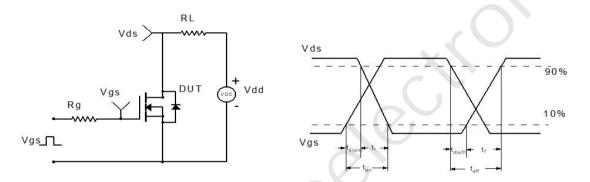


Figure 2: Resistive Switching Test Circuit & Waveform

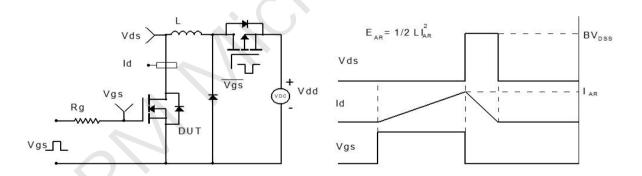


Figure 3: Unclamped Inductive Switching Test Circuit& Waveform

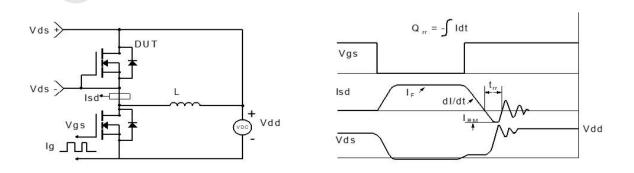
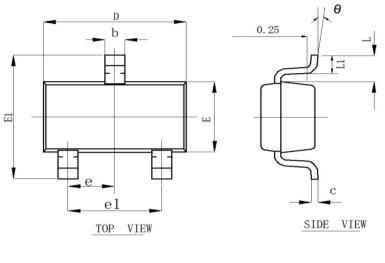


Figure 4: Diode Recovery Test Circuit & Waveform

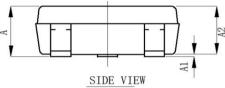
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Package Mechanical Data(SOT-23)



SYMBOL	MIN	MAX	
A	0.900	1. 150	
A1	0.000	0.100	
A2	0.900	1.050	
b	0.300	0.500	
С	0.080	0. 150	
D	2.800	3. 000	
Е	1. 200	1.400	
E1	2. 250	2.550	
L	0. 550 REF.		
θ	0°	8°	
L1	0.300	0.500	
e	0.950 TYP.		
e ₁	1.800	2.000	



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